Dawn Coating Summary S. Penn

Current Research

- Ideal Glass (Heated Substrate, Ion-Beam Assist, IBS)
 - Rapid Data Acquisition: Multimodal & Nodal Suspension
- Stabilized, High-T Annealed, Metal-oxide:
- Stabilized, Nanolayer Coatings
- Crystalline Coatings: AlGaAs & AlGaP
- **a-Si:** (Voyager, 1.5 µm) Ideal Glass
 - Cryogenic Low loss: 2 x 10⁻⁶
 - Absorption < 20 ppm, (and lowering??)

A+: Advanced LIGO improved

With Advanced LIGO at full power (P_{in} = 125 W) Quantum Noise reaches Coating Thermal Noise

Injecting frequencydependent squeezed light lowers Quantum Noise (2018?)

aLIGO Noise Curve: P in = 125.0 W Quantum Seismic Newtonian Suspension Thermal Coating Brownian Coating Thermo-optic Substrate Brownian 10⁻²² Excess Gas Total noise Strain [1/v/Hz] 10⁻²³ 10⁻²⁴ 10^{3} 10¹ 10^{2} Frequency [Hz]

Coating Thermal Noise reduced by 2x (2020?). → BNS detection range to 340 Mpc

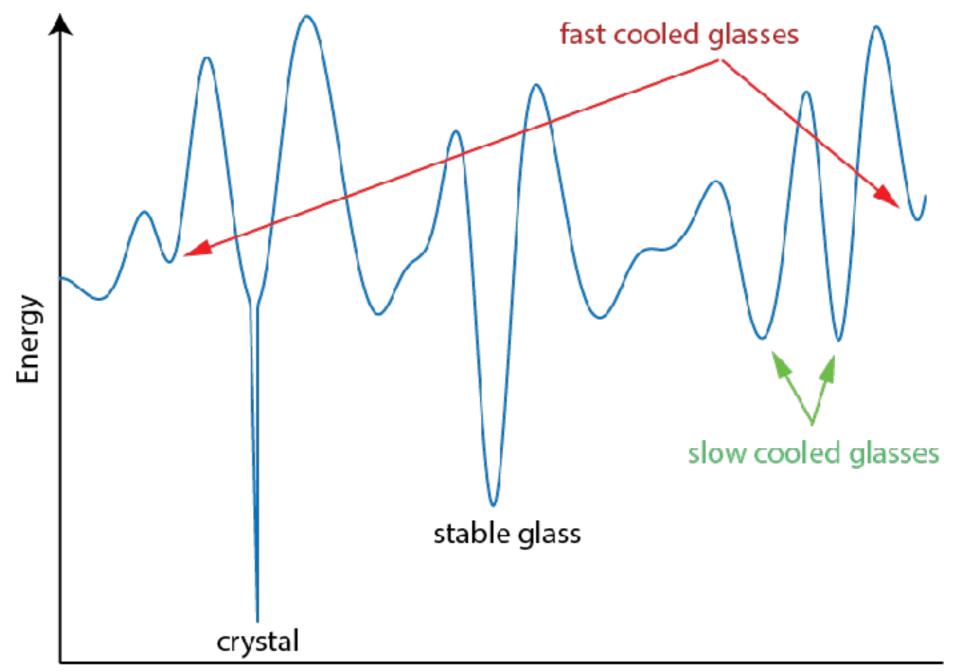
How do we lower Coating Thermal Noise by 2x in 3-4 years?

Center for Coating Research

- **Dawn II Meeting:** Talks & discussion refined ideas for CCR
- Final Proposal: 10 institutions, \$4M
- Research:
 - Ideal Glass
 - Stabilized coatings
 - Nanolayer coatings
- Funding???

Energy Landscape And Stable Glasses

- Potential energy is a function of the position of all particles (3N d.o.f.s!!)
- · Going lower means fewer internal dissipations due to two level systems



Configuration space

Parisi et al. Nature Materials 12, 94 (2013)

Increased Mobility Lowers Loss?

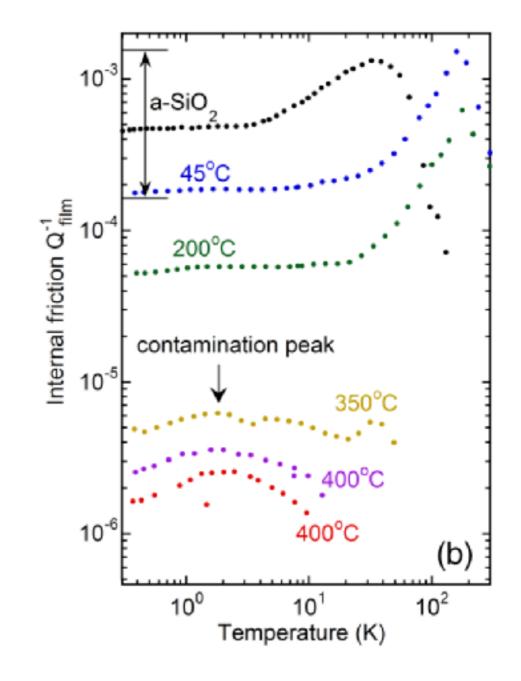
Ultrastable a-Silicon:

• EBD coating on 400 C substrate, $\phi = 2 \times 10^{-6}$ [Liu , et alia, PRL 113, 025503 (2014)].

Ultrastable High-index Metal-oxide Coating:

Goal: allow molecules that are freshly deposited to explore a a larger part of the energy landscape

- 1. Increase the substrate temperature to increase the mobility (showed very promising results with a-Si)
- 2. Reduce the deposition speed (giving more time to the newly deposited molecules to move around before a new layer comes in).
- **3. Ion beam assisted deposition** (increase the mobility by hitting the molecules already on the surface with an additional ion beam)

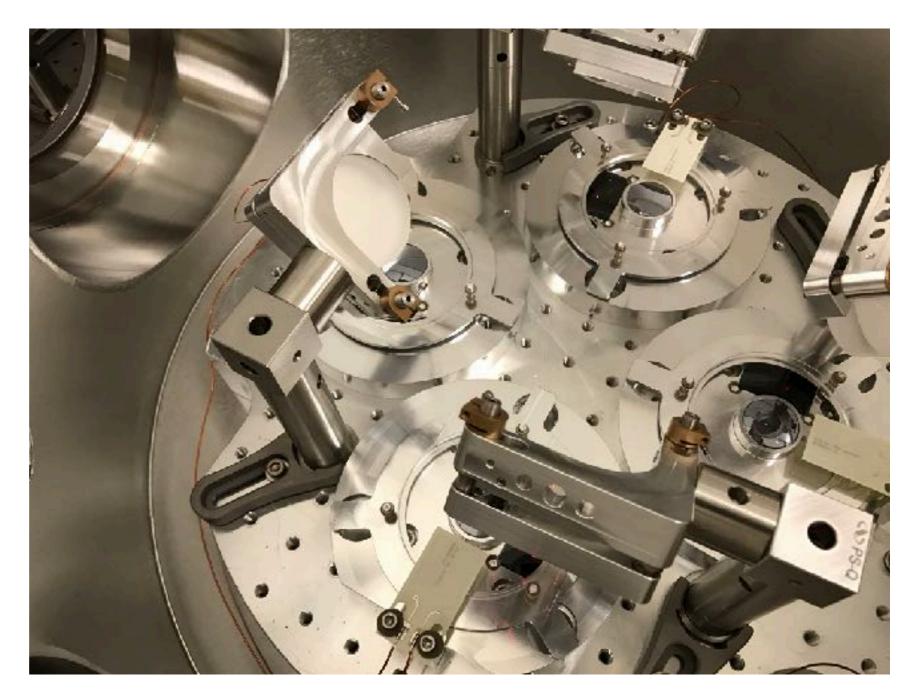


Liu , et alia, PRL 113, 025503 (2014)

Rapid Loss Measurements

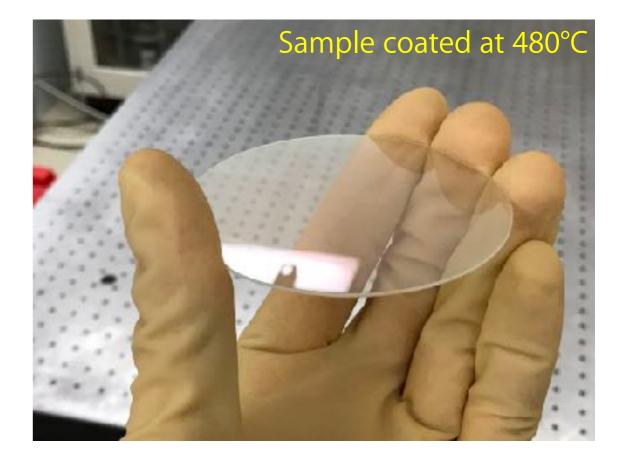
- Measure four samples in parallel in the same chamber
- Digital control system running at a sampling rate of 65 kHz allows us to excite and measure all modes simultaneously

	Time
Install samples and align	15 min.
Pump down	2 hours
Measurement time (depends on Q)	2-5 hours
Venting	30 min.
Total	5-8 hours



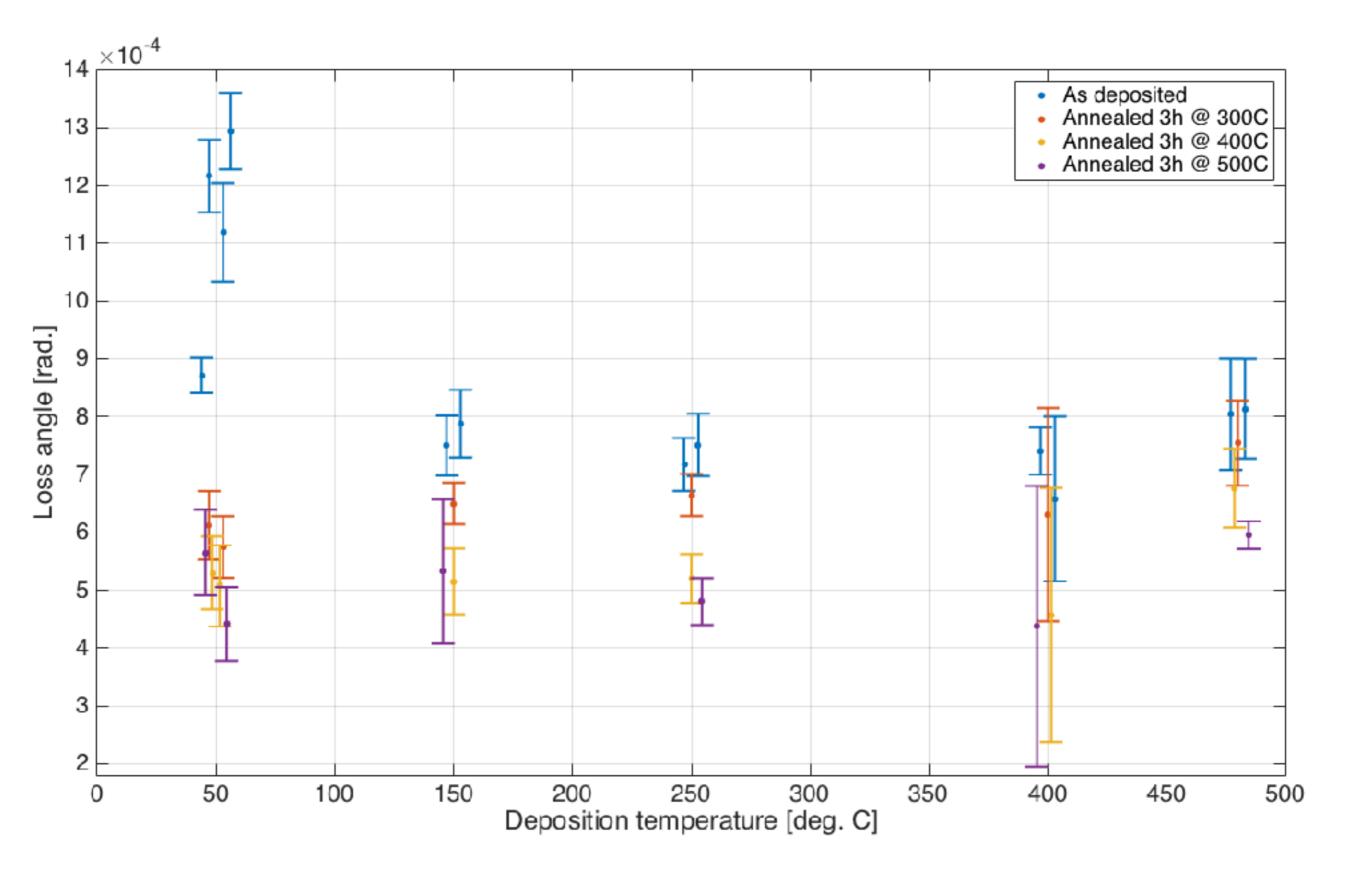
Elevated substrate temperature deposition

- Carried out with magnetron sputtering at Université de Montréal / Polytechnique Montréal
 - Pure tantala, 1 micron thick layer
- Five temperatures:
 - Room temperature (50°C, 150°C, 250°C, 400°C and 480°C)
 - Sample coated at 480°C looks hazy
- Coating mechanical losses measured at Caltech
 - As deposited, and after annealing (3 hours @ 300°C / 400°C / 500°C)
- Ellipsometry measurements at Montreal
- XRD measurements at HWS and Stanford



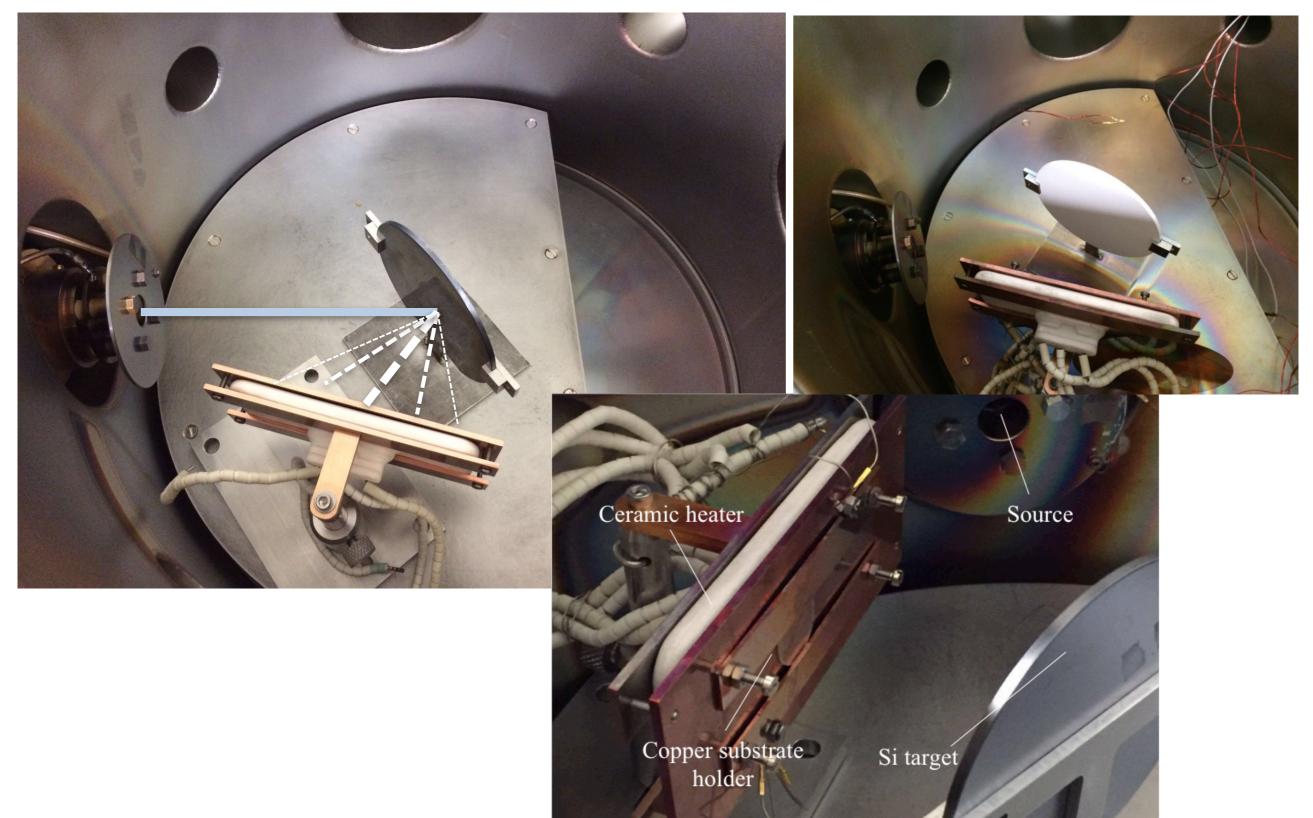
- CMS-18 sputtering system by Kurt J. Lesker
- Base pressure typically 8-9e-8 Torr
- Deposition conditions: 2 mTorr, 450 W on a three-inch Ta target, 60% O2 vs. Ar, rotation of 20 RPM, pre-sputtered with O2 for 20 minutes prior to deposition to ensure a stable discharge
- All substrates were pre-cleaned using an O2/ Ar plasma (50% O2 vs. Ar) for 600 s at 8 mTorr at around -100V.

Effect of Annealing



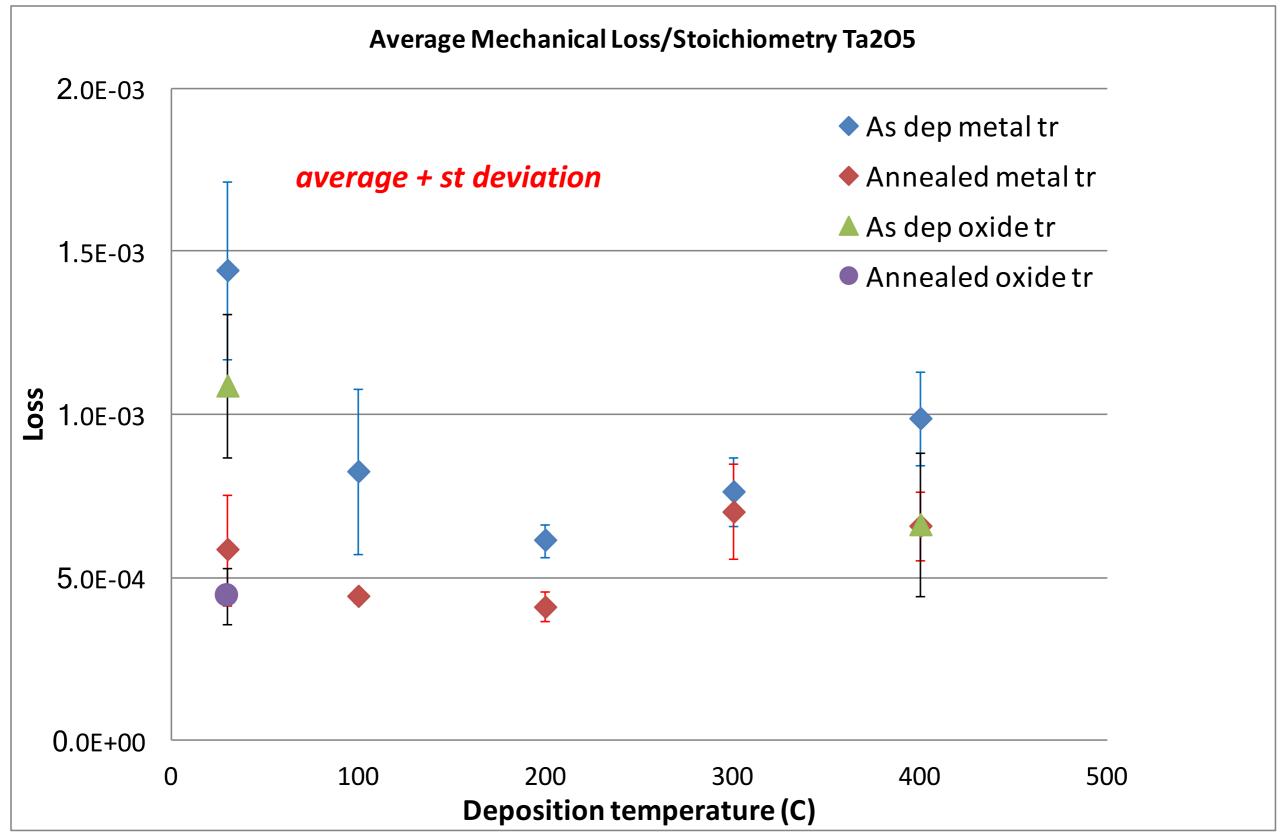
Development of ECR-IBD





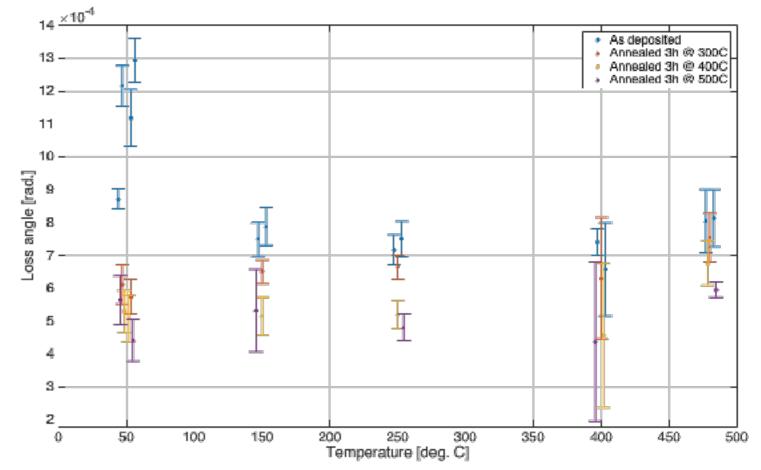
UWS Ta₂O₅ mechanical loss





Heated Substrate Results

- Substrate temperature has an effect on mechanical losses (before annealing)
 - Crystallization at relatively low temperature 480°C, instead of ~600°C observed normally when annealing post deposition
 - Seems to indicate that elevated temperature deposition is somehow more efficient than post deposition annealing
- However, annealing has still a large impact and reduced losses down to a level of 5x10⁻⁴



- Coating deposited at 400 C is also improved a bit

A+: Stabilized, Annealed Amorphous Coatings

Silica-Stabilized Coatings:

- Stabilized coating \implies Higher annealing T \implies Lower Mechanical Loss ϕ
- Added silica lowers index \Longrightarrow Thicker coatings \Longrightarrow Higher Mechanical Loss ϕ
- Silica(30%)-Hafnia $T_{anneal} = 600 \text{ C}$. $\phi = 3 \times 10^{-4} \text{ at } 14 \text{ K}$
- Silica(20%)-Zirconia $T_{anneal} = 800 \text{ C}$. $\phi = 2 \times 10^{-4} \text{ at } 300 \text{ K}$
- No net benefit.

P. Murray: <u>DCC-G1400275</u>

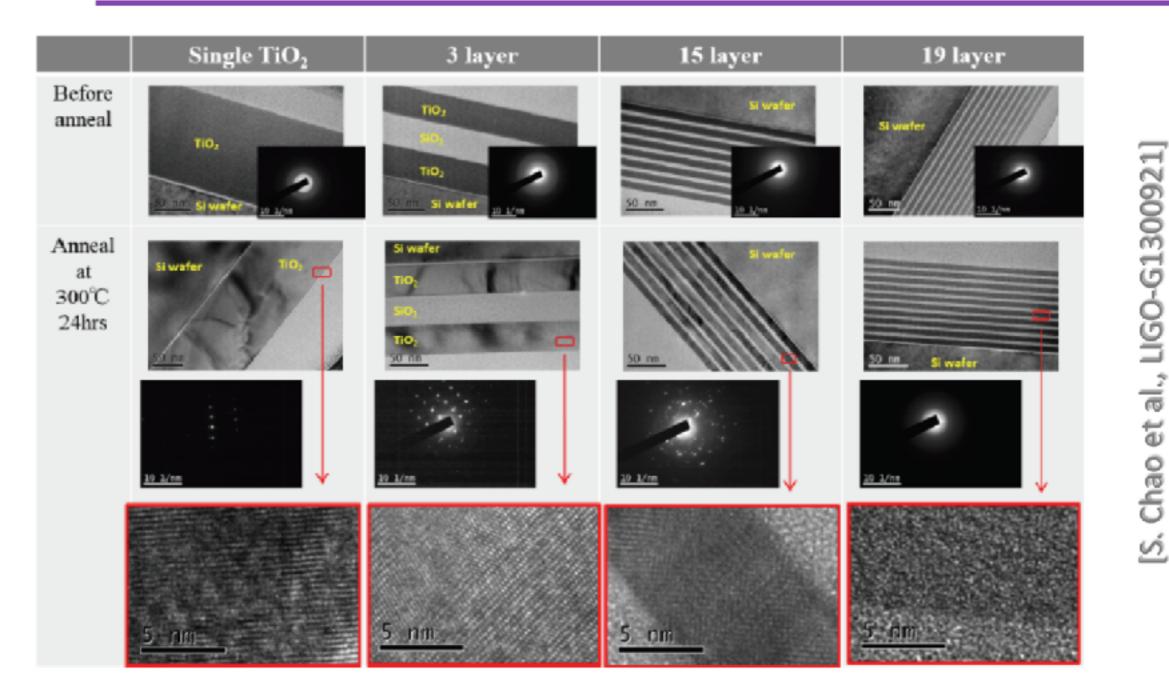
Mutually-Stabilized Coatings:

- Stabilized coating \implies Higher annealing T \implies Lower Mechanical Loss ϕ
- Zirconia(34%)-Tantala $T_{anneal} = 800 \text{ C}, n \approx 2.1-2.2, Y = 134 \text{ GPa}$
- $\phi = 1.4 \times 10^{-4}$ (shear), $\phi = 4 \times 10^{-4}$ (bulk) [Preliminary] Potentially useful. New Run

Nano-Coatings:

- Thinner coatings layers pin the high index material to prevent crystallization
- Stabilized Titania/Silica coatings: 19 sublayers, $T_{anneal} = 300 \text{ C}$, $\phi \approx 10^{-4}$
- New Sannio Coating facility to move beyond few nm layer limit to <= 1 nm.

Nanolayer coatings: I. Pinto, R. DeSalvo, S. Chao TEM Before/After Annealing



TEM shows that no significant across-interface diffusion occurs during annealing

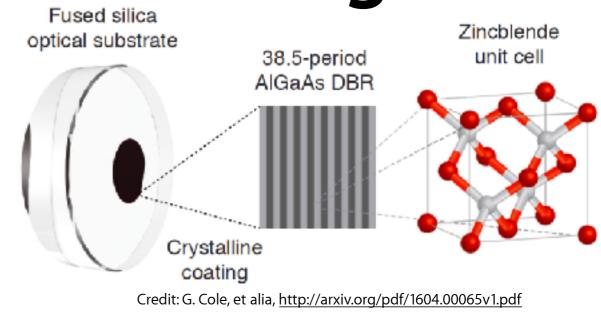
New University Sannio Coating facility to move beyond few nm layer limit to <= 1 nm.

Voyager: AlGaAs Coatings

GaAs/Al_xGa_{1-x}As crystal

MBE grown, then transferred Currently limited to 20 cm diameter

Compatible with 1064–1550 nm



At 1064 nm: Absorption < 1 ppm, Scatter < 3 ppm, T = 10 ppm

At 1530 nm: Absorption $\approx 3.6 \pm 1.3 \text{ ppm}$ [J. Steinlechner, Class. Quantum Grav. 32 (2015) 105008]

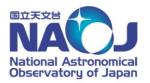
Mechanical Loss:

Optical cavities: (1 mm beam, 1064 nm) $\phi = 2 \times 10^{-5}$ [Cole, et al., *Nature Photonics*, vol. 7, pp. 644–650, Aug. 2013] Mechanical Ringdown:

Initial Bonding: $\phi = 3 \times 10^{-5}$ (bulk), $\phi = 5 \times 10^{-4}$ interface shear modes) New Bonding: In progress



The process

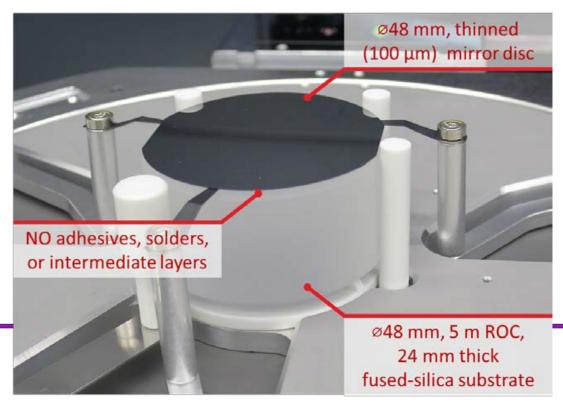


• Epitaxial growth on GaAs wafer

- AIGaAs multilayer with varying AI content for index contrast
 - » high index layers consist of binary GaAs thin films
 - » 8% Ga incorporated in low index AlGaAs layers to slow oxidation in ambient
- High quality epitaxy requires a lattice matched substrate, same crystalline symmetry, minimal deviation of lattice parameter (atomic spacing)
- Transfer and bonding to the final optical substrate
 - mirror completely removed from the wafer and bonded to desired substrate







Voyager: AlGaP Coatings

GaP/AlGaP \approx lattice matched to Silicon

Coating grown using MBE on substrate

• Chamber limits size to \approx 300 mm

No bonding. Low interface losses.

Buffer layer required to adapt lattice

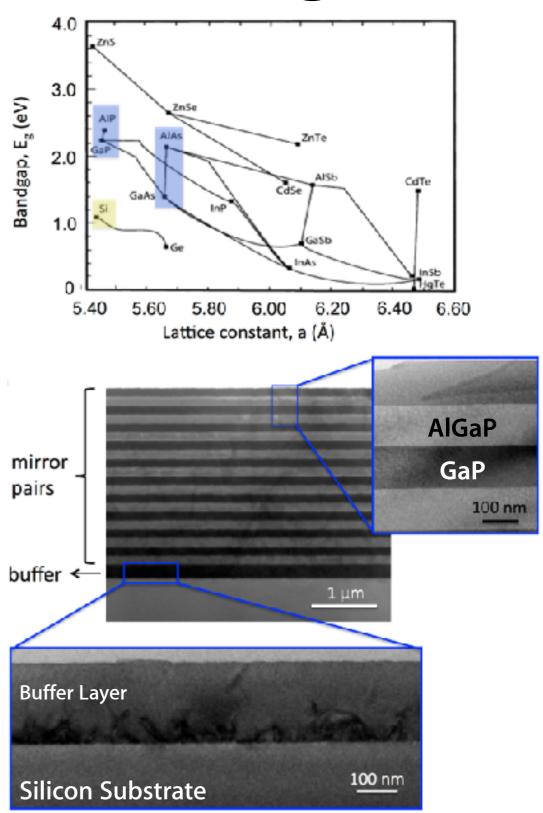
- Adapts lattice spacing, stress change
- Antiphase defects near interface

Cryogenic Loss: $\phi = 1.4 \times 10^{-5}$ at 12 K

High Absorption: 2.3%

• Due to antiphase defects?





A. Lin, et alia, <u>https://dcc.ligo.org/DocDB/0104/G1300580/001/ACLin-GWADW2013v2.pdf</u>